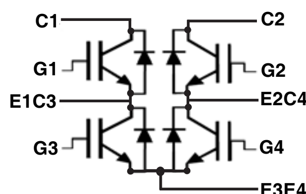
IXYS Preliminary Technical Information

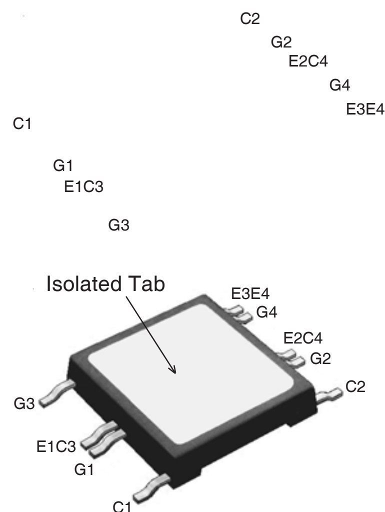
High Voltage, High Gain BIMOSFET™ Monolithic Bipolar MOS Transistor

MMIX4B12N300

V_{CES} = 3000V
I_{C110} = 11A
$V_{CE(sat)} \leq$ 3.2V

(Electrically Isolated Tab)





G = Gate E = Emitter
C = Collector

Symbol	Test Conditions	Maximum Ratings	
V_{CES}	T_C = 25°C to 150°C	3000	V
V_{CGR}	T_J = 25°C to 150°C, R_{GE} = 1MΩ	3000	V
V_{GES}	Continuous	± 20	V
V_{GEM}	Transient	± 30	V
I_{C25}	T_C = 25°C	26	A
I_{C110}	T_C = 110°C	11	A
I_{CM}	T_C = 25°C, V_{GE} = 19V, 1ms	98	A
	10ms	52	A
SSOA	V_{GE} = 15V, T_{VJ} = 125°C, R_G = 20Ω	I_{CM} = 98	A
(RBSOA)	Clamped Inductive Load	1500	V
P_C	T_C = 25°C	125	W
T_J		-55 ... +150	°C
T_{JM}		150	°C
T_{stg}		-55 ... +150	°C
T_L	1.6mm (0.062 in.) from Case for 10s	300	°C
T_{SOLD}	Plastic Body for 10 seconds	260	°C
F_C	Mounting Force	50..200 / 11..45	Nm/lb.in.
V_{ISOL}	50/60Hz, 1 Minute	4000	V~
Weight		8	g

Symbol	Test Conditions (T_J = 25°C Unless Otherwise Specified)	Characteristic Values Min.	Typ.	Max.	
BV_{CES}	I_C = 250μA, V_{GE} = 0V	3000			V
$V_{GE(th)}$	I_C = 250μA, V_{CE} = V_{GE}	3.0		5.0	V
I_{CES}	V_{CE} = 0.8 • V_{CES}, V_{GE} = 0V			25	μA
	Note 2, T_J = 125°C			1	mA
I_{GES}	V_{CE} = 0V, V_{GE} = ± 20V			±100	nA
$V_{CE(sat)}$	I_C = I_{C90}, V_{GE} = 15V, Note 1		2.8	3.2	V
	T_J = 125°C		3.5		V

Features

- Silicon Chip on Direct-Copper Bond (DCB) Substrate
- Isolated Mounting Surface
- 4000V~ Electrical Isolation
- High Blocking Voltage
- High Peak Current Capability
- Low Saturation Voltage

Advantages

- Low Gate Drive Requirement
- High Power Density

Applications

- Switch-Mode and Resonant-Mode Power Supplies
- Capacitor Discharge Circuits

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Symbol	Test Conditions (T_J = 25°C Unless Otherwise Specified)	Min.	Typ.	Max.	
g_{fS}	$I_C = I_{C90}$, V_{CE} = 10V, Note 1	6.5	10.8		S
$I_{C(ON)}$	V_{GE} = 20V, V_{CE} = 15V, Note 1		200		A
C_{ies}	V_{CE} = 25V, V_{GE} = 0V, f = 1MHz		1290		pF
C_{oes}			56		pF
C_{res}			19		pF
Q_g	$I_C = I_{C90}$, V_{GE} = 15V, V_{CE} = 1000V		62		nC
Q_{ge}			13		nC
Q_{gc}			8.5		nC
$t_{d(on)}$	**Resistive Switching Times, T_J = 25°C** $I_C = I_{C90}$ V_{GE} = 15V V_{CE} = 1250V, R_G = 10Ω		64		ns
t_r			140		ns
$t_{d(off)}$			180		ns
t_f			540		ns
$t_{d(on)}$	**Resistive Switching Times, T_J = 125°C** $I_C = I_{C90}$, V_{GE} = 15V V_{CE} = 1250V, R_G = 10Ω		65		ns
t_r			395		ns
$t_{d(off)}$			175		ns
t_f			530		ns
R_{thJC}				1.00	°C/W
R_{thCS}			0.05		°C/W
R_{thJA}			30		°C/W

Reverse Diode

Symbol	Test Conditions (T_J = 25°C Unless Otherwise Specified)	Min.	Typ.	Max.	
V_F	I_F = 12A, V_{GE} = 0V			2.1	V
t_{rr}	I_F = 6A, V_{GE} = 0V, -di_F/dt = 100A/μs		1.4		μs
I_{RM}	V_R = 100V, V_{GE} = 0V		21		A

Notes:

1. Pulse test, t ≤ 300μs, duty cycle, d ≤ 2%.
2. Device must be heatsunk for high temperature leakage current measurements to avoid thermal runaway.

PRELIMINARY TECHNICAL INFORMATION

The product presented herein is under development. The Technical Specifications offered are derived from data gathered during objective characterizations of preliminary engineering lots; but also may yet contain some information supplied during a pre-production design evaluation. IXYS reserves the right to change limits, test conditions, and dimensions without notice.

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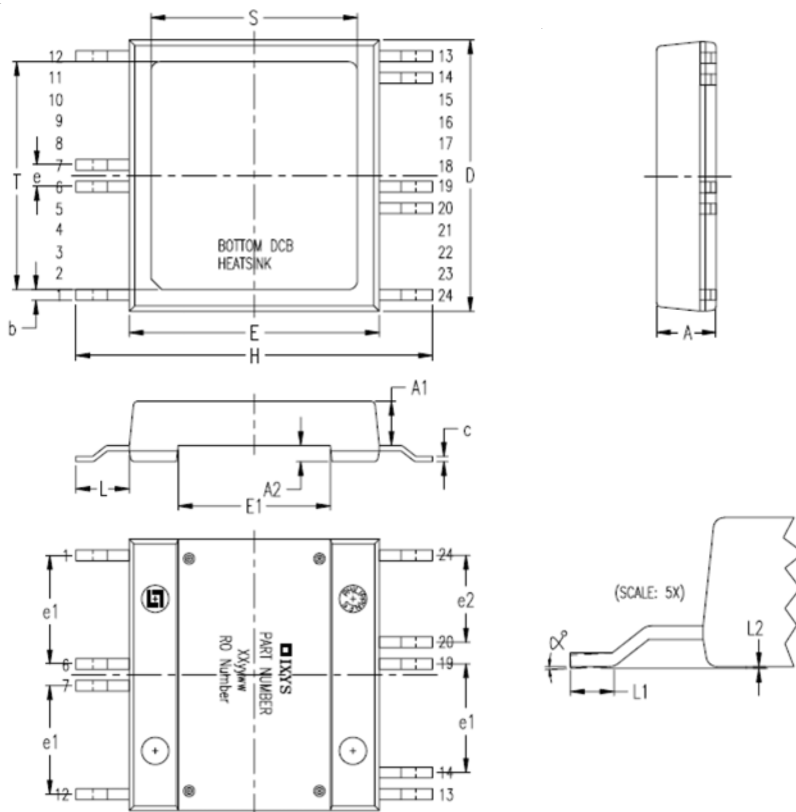
IXYS MOSFETs and IGBTs are covered by one or more of the following U.S. patents: 4,835,592 4,931,844 5,049,961 5,237,481 6,162,665 6,404,065 B1 6,683,344 6,727,585 7,005,734 B2 7,157,338B2 4,860,072 5,017,508 5,063,307 5,381,025 6,259,123 B1 6,534,343 6,710,405 B2 6,759,692 7,063,975 B2 4,881,106 5,034,796 5,187,117 5,486,715 6,306,728 B1 6,583,505 6,710,463 6,771,478 B2 7,071,537

Package Outline



SYM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	.209	.224	5.30	5.70
A1	.154	.161	3.90	4.10
A2	.055	.063	1.40	1.60
b	.035	.045	0.90	1.15
c	.018	.026	0.45	0.65
D	.976	.994	24.80	25.25
E	.898	.915	22.80	23.25
E1	.543	.559	13.80	14.20
e	.079 BSC		2.00 BSC	
e1	.394 BSC		10.00 BSC	
e2	.315 BSC		8.00 BSC	
H	1.272	1.311	32.30	33.30
L	.181	.209	4.60	5.30
L1	.051	.067	1.30	1.70
L2	.000	.006	0.00	0.15
S	.736	.760	18.70	19.30
T	.815	.839	20.70	21.30
α	0	4°	0	4°

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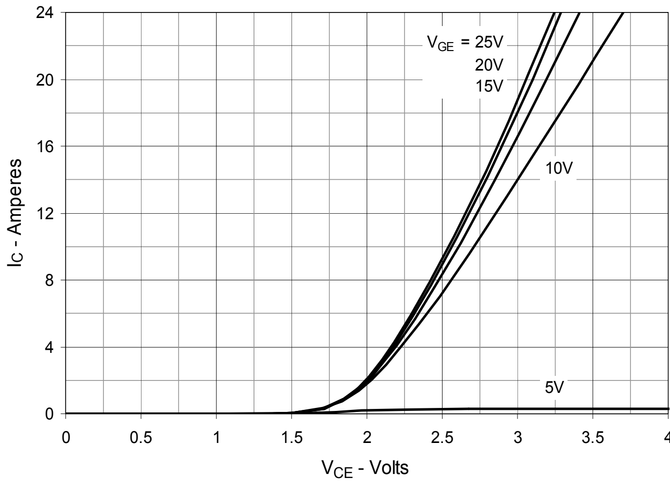

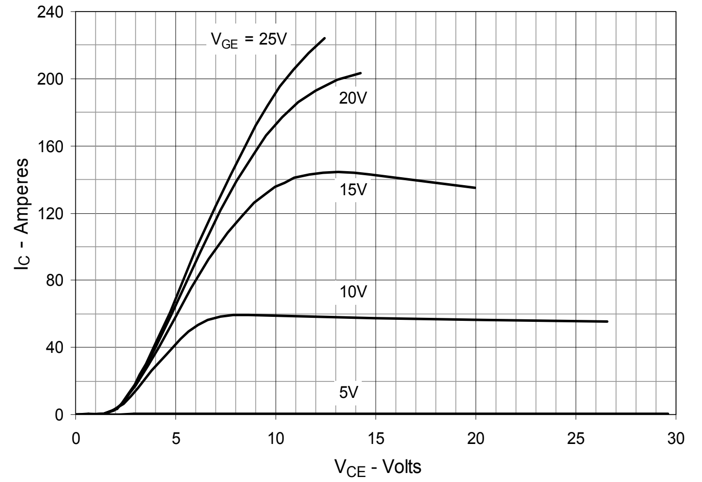

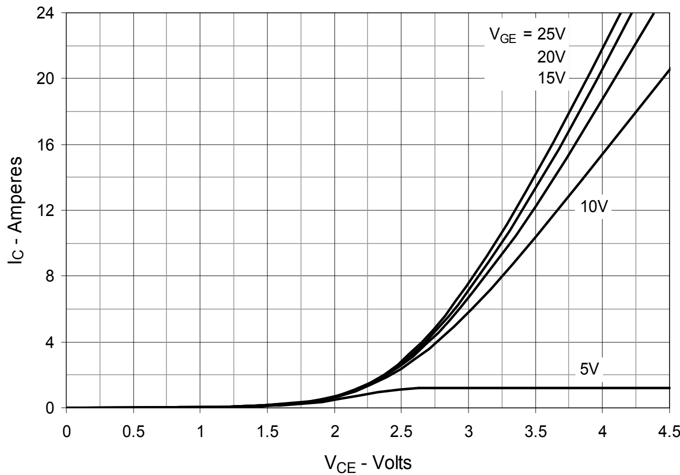

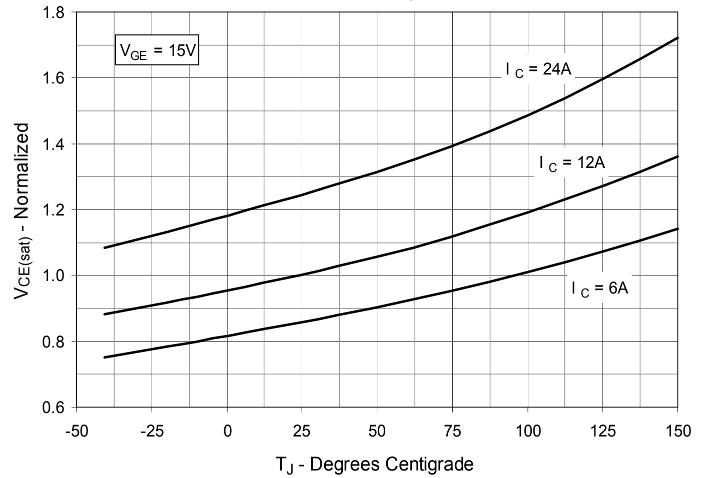

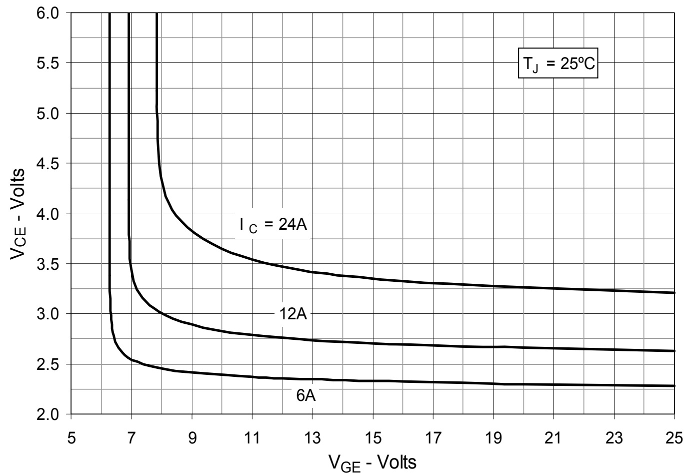

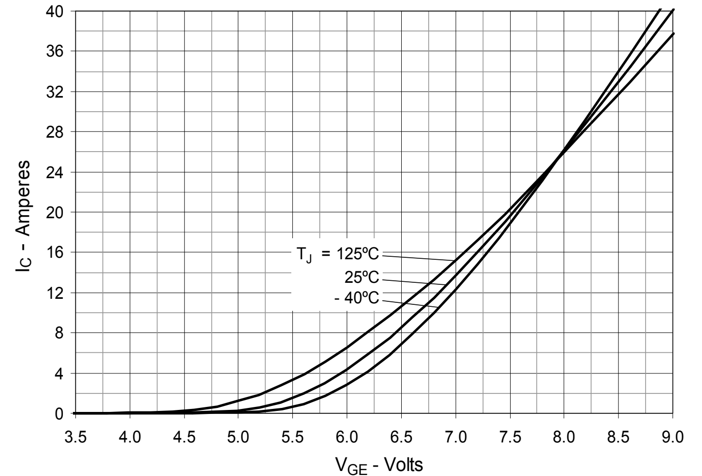

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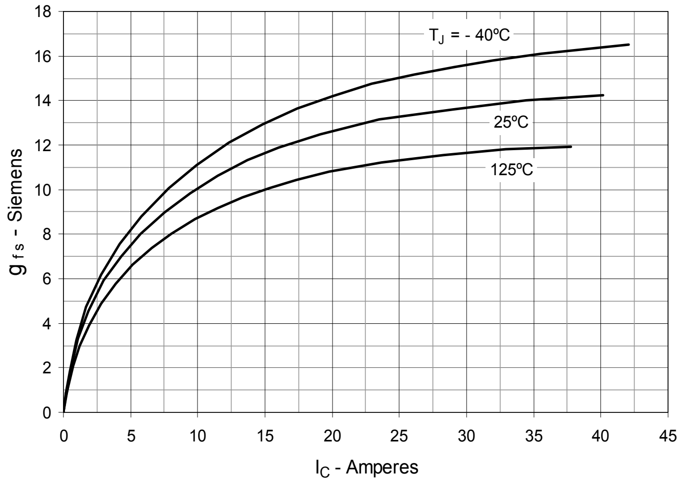

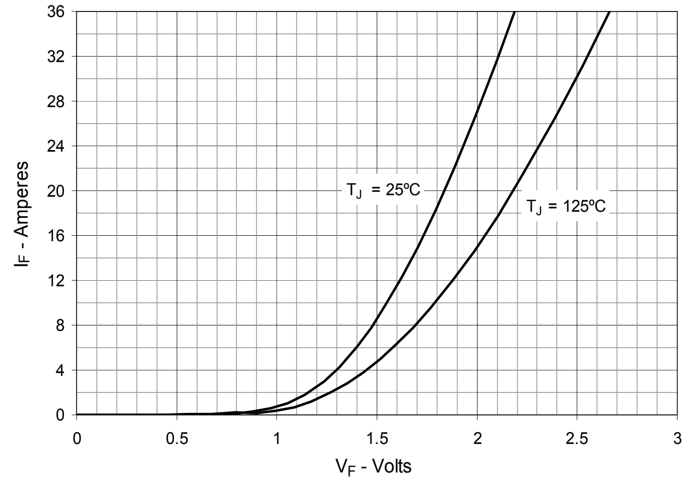

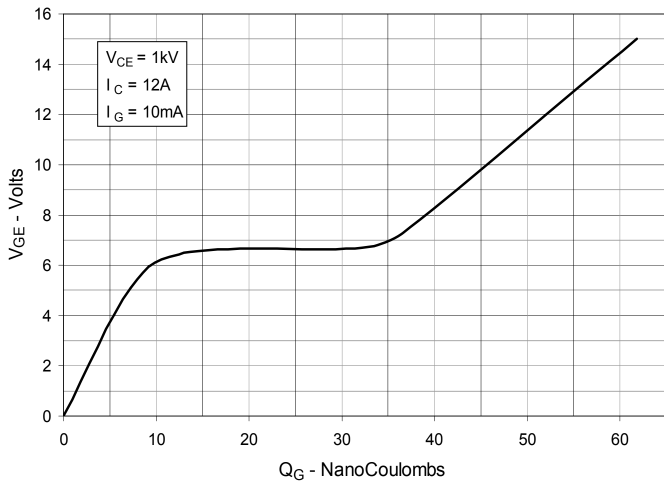

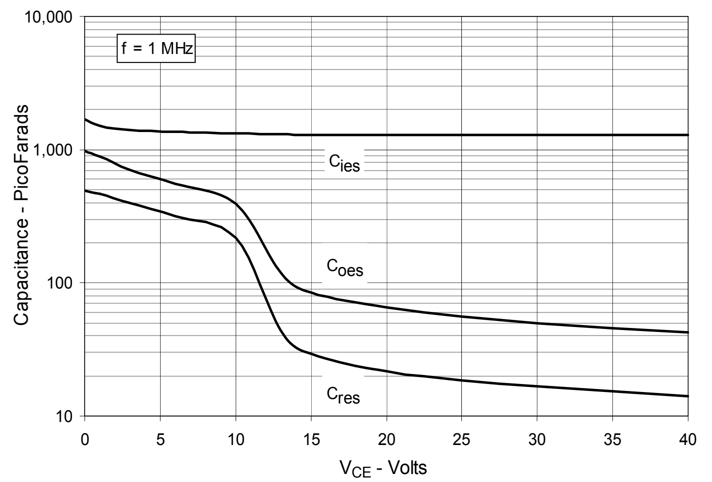

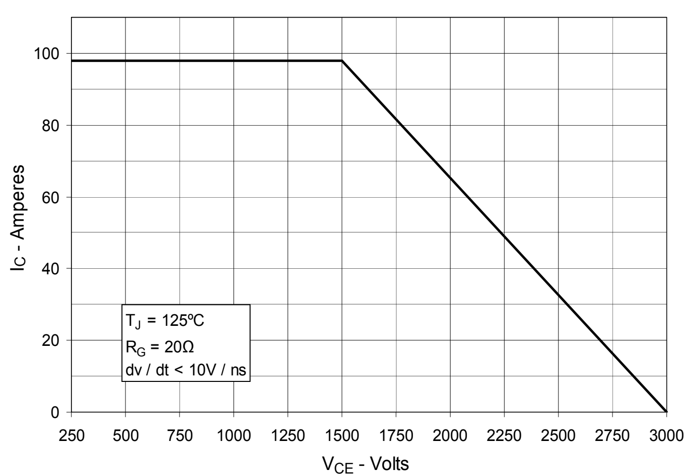

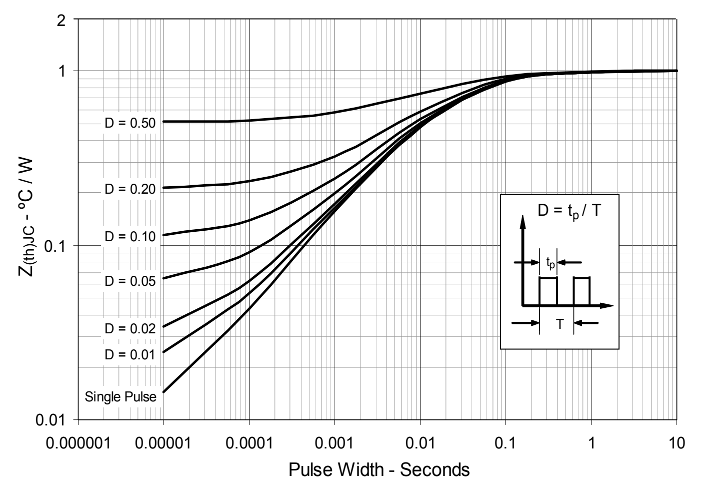

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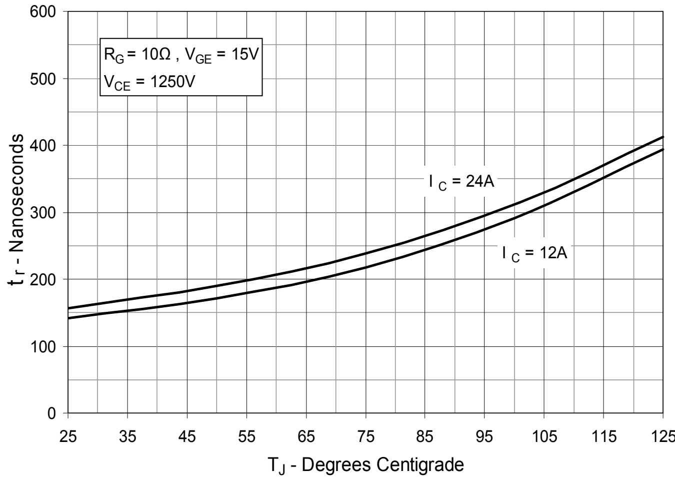

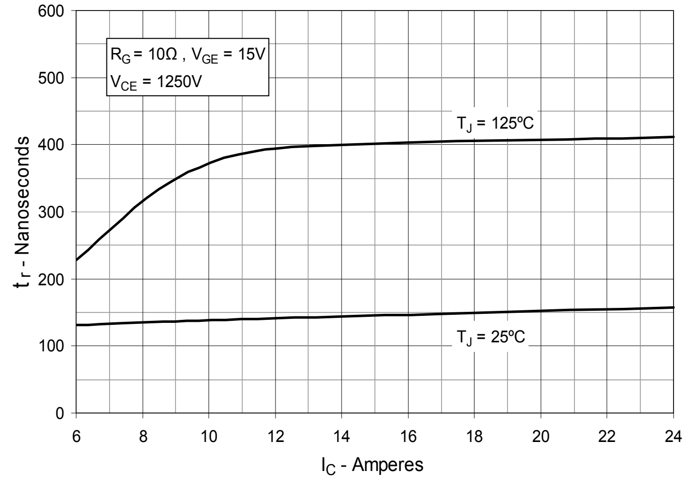

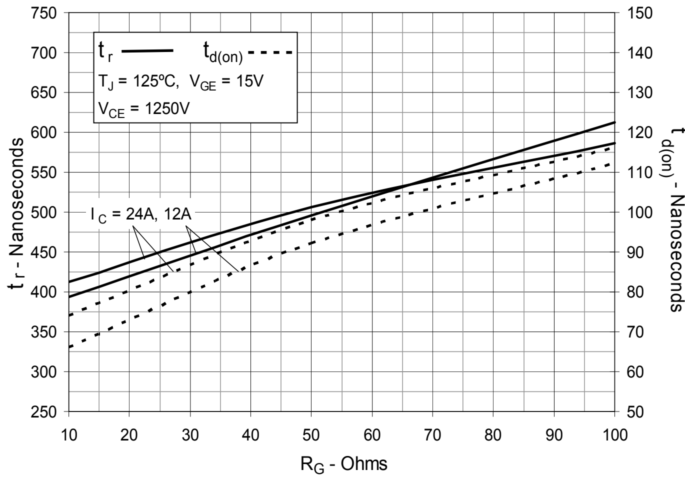

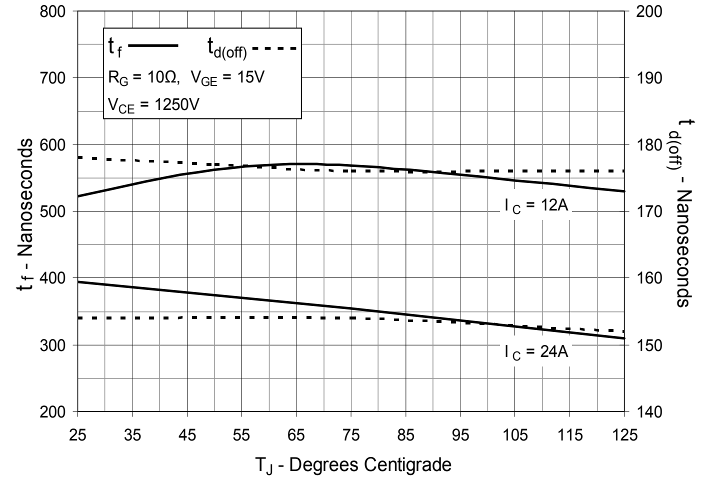

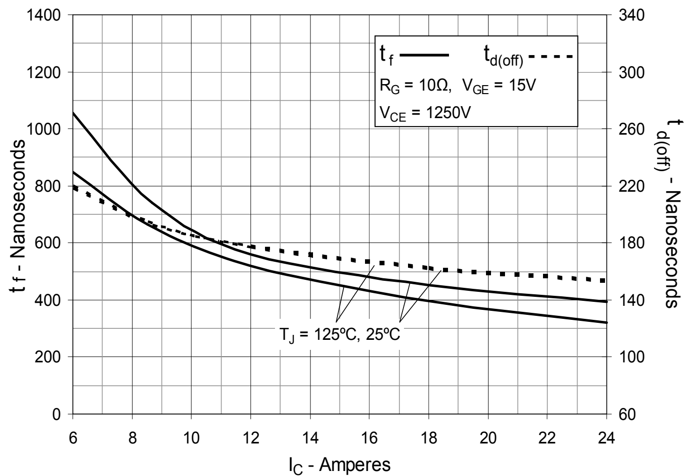

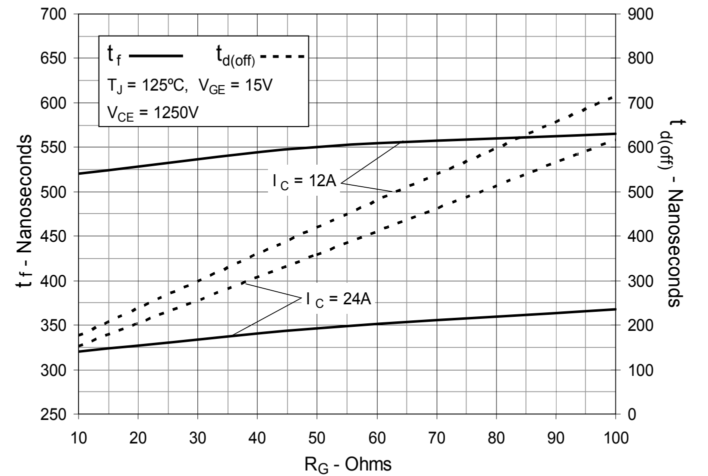

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